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Substitute for form 1449A/PTO				Complete if Known	
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> (use as many sheets as necessary)				Application Number	09/832,867
				Filing Date	April 12, 2001
				First Named Inventor	Shunpei YAMAZAKI et al.
				Group Art Unit	2822
				Examiner Name	M. Lewis
Sheet	1	of	2	Attorney Docket Number	0756-2294

U.S. PATENT DOCUMENTS						
Examiner Initials <sup>1</sup>	Cite No. <sup>1</sup>	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code <sup>2</sup> (if known)			
ML		2001/0055841		Yamazaki et al.	12/27/2001	
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Examiner Initials <sup>1</sup>	Cite No. <sup>1</sup>	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>4</sup>
		Office <sup>3</sup>	Number <sup>4</sup>	Kind Code <sup>5</sup> (if known)				
ML		JP	08-160464			06/21/1996		Abst.
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		JP	2000-315798			11/14/2000		Abst.

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS								
Examiner Initials <sup>1</sup>	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T <sup>2</sup>			
ML		R. SHIMOKAWA, et al., <i>Characterization of High-Efficiency Cast-Si Solar Cell Wafers by MBIC Measurement</i> , Japanese Journal of Applied Physics, May 1, 1988, Volume 27, No. 5, Pages 751-758.						
Examiner Signature					Date Considered			
					4/20/06			

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<b>Group Art Unit</b>	2822
<b>Examiner Name</b>	M. Lewis
<b>Attorney Docket Number</b>	0756-2294

*(use as many sheets as necessary)*

Sheet	2	of	2	Attorney Docket Number	0756-2294
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## U.S. PATENT DOCUMENTS

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## FOREIGN PATENT DOCUMENTS

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<b>First Named Inventor</b>	Shunpei YAMAZAKI, et al.
<b>Group Art Unit</b>	2822
<b>Examiner Name</b>	Monica Lewis
<b>Attorney Docket Number</b>	0756-2294

Sheet	1	of	1
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## U.S. PATENT DOCUMENTS

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ML		Takada, et al., PROCEEDINGS OF 46 <sup>TH</sup> SPRING MEETINGS OF THE SOCIETY FOR APPLIED PHYSICS OF JAPAN, 28P-V-8, page 1316.	NONE
		<del>Yoshitara, EKISHO, Vol. 3, No. 3, pp. 190-194.</del>	<del>NONE</del>

Examiner Signature		Date Considered	1/30/06
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